

STD100N3LF3 STU100N3LF3

N-channel 30V - 0.0045Ω - 80A - DPAK - IPAK Planar STripFET™ II Power MOSFET

General features

Туре	V _{DSSS}	R _{DS(on)}	I _D	Pw
STD100N3LF3	30 V	<0.0055 Ω	80 A ⁽¹⁾	110 W
STU100N3LF3	30 V	<0.0055 Ω	80 A ⁽¹⁾	110 W

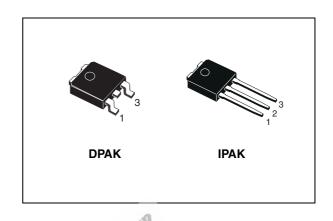
- 1. Current limited by package
- 100% avalanche tested
- Logic level threshold

Description

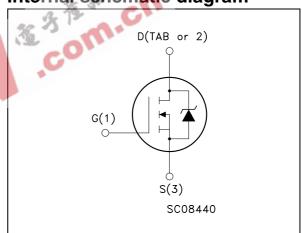
This Power MOSFET is the latest refinement of STMicroelectronics unique "Single Feature SizeTM" strip-based process. The resulting transistor shows extremely high packing density for low on-resistance, rugged avalanche characteristics, low gate charge and less critical alignment steps therefore a remarkable manufacturing reproducibility. This new improved device has been specifically designed for Automotive application and DC-DC converters.

Applications

■ Switching application



Internal schematic diagram



Order codes

Part number	Marking	Package	Packaging
STD100N3LF3	100N3LF3	DPAK	Tape & reel
STU100N3LF3	100N3LF3	IPAK	Tube

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Electrical ratings 1

Absolute maximum ratings Table 1.

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (V _{GS} = 0)	30	V
I _D ⁽¹⁾	Drain current (continuous) at T _C = 25°C	80	Α
I _D	Drain current (continuous) at T _C =100°C	70	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	320	Α
P _{TOT}	Total dissipation at T _C = 25°C	110	W
	Derating factor	0.73	W/°C
dv/dt (3)	Peak diode recovery voltage slope	3.9	V/ns
T _{stg}	Storage temperature	-55 to 175	°C
T_J	Max. operating junction temperature	-33 to 173	

- 1. Current limited by package.
- 2. Pulse width limited by safe operating area
- 3. $I_{SD} \le 80A$, di/dt ≤ 360 A/ μ s, $V_{DS} \le V_{(BR)DSS}$, $T_J \le T_{JMAX}$

Thermal data Table 2.

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C	
Value	Unit
1.36	°C/W
100	°C/W
275	°C
	1.36

Table 3. **Avalanche characteristics**

Symbol	Parameter	Value	Unit
I _{AR}	Not-repetitive avalanche current (pulse width limited by T _J max)	40	Α
E _{AS}	Single pulsed avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AV}$, $V_{DD} = 24$ V	500	mJ

2 Electrical characteristics

(T_{CASE}=25°C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250\mu A, V_{GS} = 0$	30			V
I _{DSS}	Zero gate voltage drain current (V _{GS} = 0)	$V_{DS} = Max rating,$ $V_{DS} = Max rating @ 125°C$			1 10	μ Α μ Α
I _{GSS}	Gate body leakage current (V _{DS} = 0)	V _{GS} = ±20V			±200	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1			٧
		$V_{GS} = 10V, I_D = 40A$ $V_{GS} = 5V, I_D = 20A$		0.0045 0.008	0.0055 0.01	Ω Ω
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 40 A @125°C V _{GS} = 5 V, I _D = 20 A @125°C	8-	0.0068		Ω
		I _D = 20 A @125°C		0.0146		Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 10 V _, I _D = 15A		31		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25V, f = 1 \text{ MHz},$ $V_{GS} = 0$		2060 728 67		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V_{DD} = 24V, I_{D} = 80A V_{GS} = 5V Figure 15 on page 9		20 7 7.5	27	nC nC nC
R_{G}	Gate input resistance	f = 1MHz gate DC Bias = 0 Test signal level = 20mV Open drain		1.9		Ω

^{1.} Pulsed: pulse duration=300µs, duty cycle 1.5%

Table 6. **Switching times**

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r t _{d(off)} t _f	Turn-on delay time Rise time Turn-off delay time Fall time	V_{DD} = 15V, I_D = 40A, R_G =4.7 Ω , V_{GS} =10V Figure 14 on page 9		9 205 31 35		ns ns ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min	Тур.	Max	Unit
I _{SD}	Source-drain current				80	Α
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)				320	Α
V _{SD} ⁽²⁾	Forward on voltage	$I_{SD} = 40A, V_{GS} = 0$			1.3	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I_{SD} = 80A, di/dt = 100A/ μ s, V_{DD} = 25V, T_{J} = 150°C Figure 16 on page 9	-	40 40 2		ns μC A
	dth limited by safe operating area pulse duration=300μs, duty cycle 1.5	5% & COM.				



2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

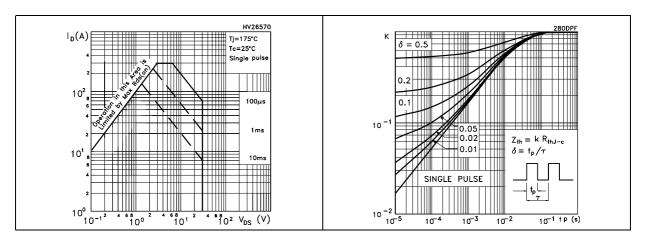


Figure 3. Output characteristics

Figure 4. Transfer characteristics

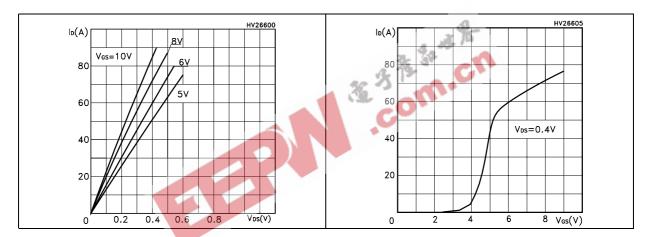
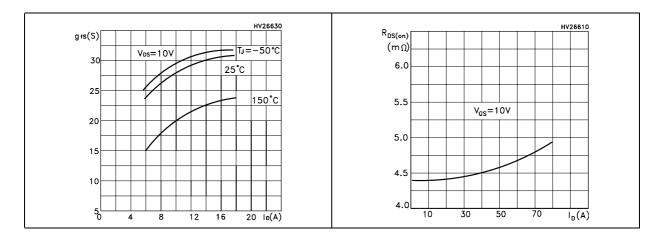


Figure 5. Transconductance

Figure 6. Static drain-source on resistance



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Gate charge vs gate-source voltage Figure 8. Capacitance variations Figure 7.

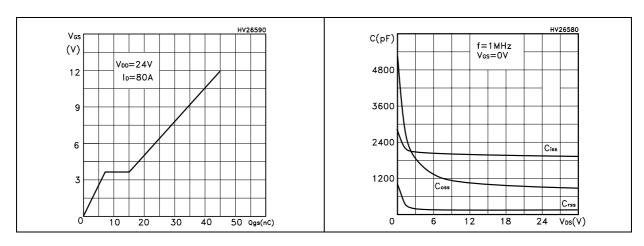


Figure 9. Normalized gate threshold voltage Figure 10. Normalized BVDSS vs temperature vs temperature

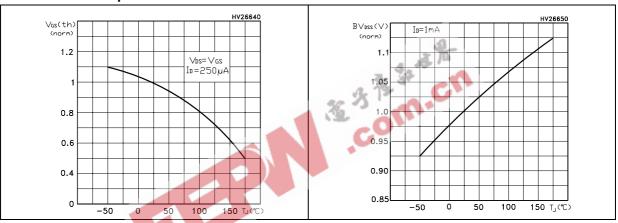
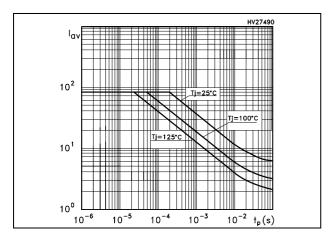


Figure 11. Normalized on resistance vs

temperature characteristics HV26620 HV26660 VsD Ros(on) (norm) 1. 2.2 TJ=-50℃ 1.8 1.0 25℃ 1.4 __ 175℃ V_Gs= 10V 1.0 0.8 ID=40A 0.6 0.7 0.6 L 0 100 -50 50 150 TJ(℃) 30 60 90 IsD(A)

Figure 12. Source-drain diode forward

Figure 13. Allowable lav vs time in avalanche



The previous curve gives the single pulse safe operating area for unclamped inductive loads, under the following conditions:

$$P_{D(AVE)} = 0.5 * (1.3 * BV_{DSS} * I_{AV})$$

$$E_{AS(AR)} = P_{D(AVE)} * t_{AV}$$

Where:

I_{AV} is the allowable current in avalanche

avalanche ' P_{D(AVE)} is the average power dissipation in avalanche (single pulse)

t_{AV} is the time in avalanche

3 **Test circuit**

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

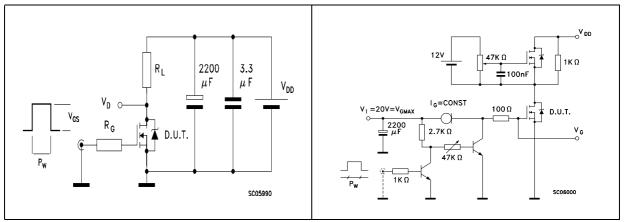
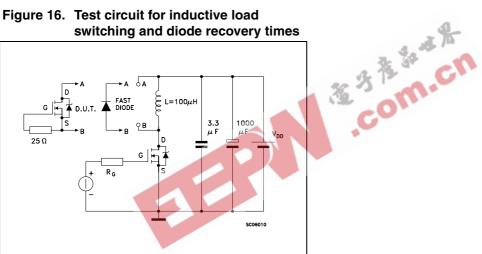


Figure 16. Test circuit for inductive load switching and diode recovery times



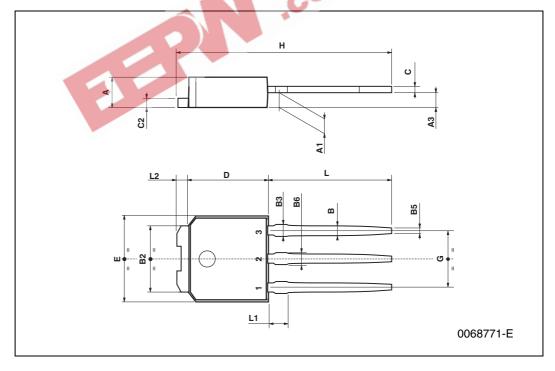
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



TO-251 (IPAK) MECHANICAL DATA

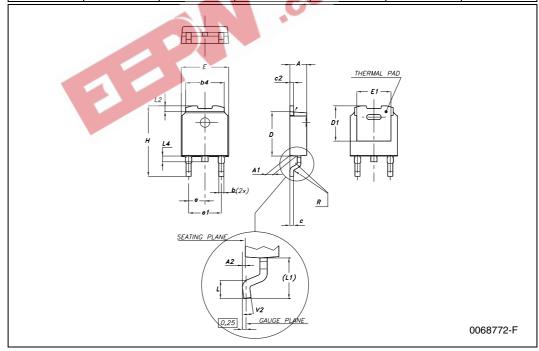
DIM.		mm				
DIN.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
Α	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
В	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
В3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
С	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
Е	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
Н	15.9		16.3	0.626		0.641
L	9		9.4	0.354	-	0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	17) * "	0.031	0.039



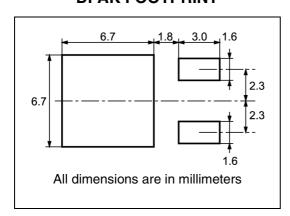
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DPAK MECHANICAL DATA

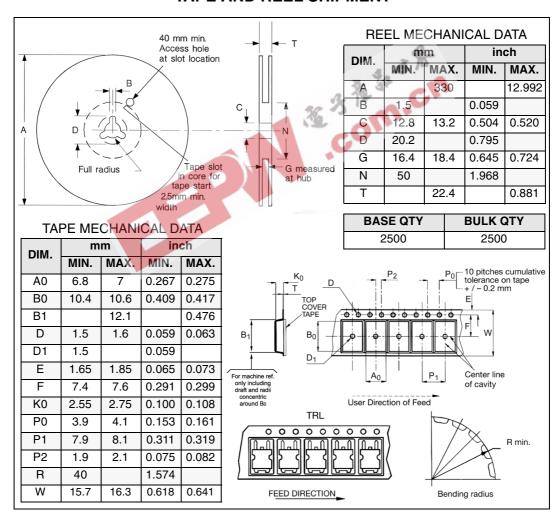
DIM.		mm.			inch			
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.		
Α	2.2		2.4	0.086		0.094		
A1	0.9		1.1	0.035		0.043		
A2	0.03		0.23	0.001		0.009		
В	0.64		0.9	0.025		0.035		
b4	5.2		5.4	0.204		0.212		
С	0.45		0.6	0.017		0.023		
C2	0.48		0.6	0.019		0.023		
D	6		6.2	0.236		0.244		
D1		5.1			0.200			
E	6.4		6.6	0.252		0.260		
E1		4.7			0.185			
е		2.28			0.090			
e1	4.4		4.6	0.173		0.181		
Н	9.35		10.1	0.368		0.397		
L	1			0.039	•			
(L1)		2.8		3,35-1"	0.110			
L2		0.8		E 38	0.031			
L4	0.6		1 %	0.023	-	0.039		
R		0.2	4 36	Me.	0.008			
V2	0°		8°	0°		8°		



5 Packaging mechanical data DPAK FOOTPRINT



TAPE AND REEL SHIPMENT



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6 Revision history

Table 8. Revision history

Date	Revision	Changes
07-Feb-2006	1	Initial release.



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